

<b>Notice of References Cited</b>	Application/Control No. 10/806,420		Applicant(s)/Patent Under Reexamination SHIN ET AL.	
	Examiner ABDULLAH RIYAMI		Art Unit 2474	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0105956	08-2002	Saito, Shin	370/401
*	B	US-2003/0161287	08-2003	Venkitaraman et al.	370/338
*	C	US-2006/0013170	01-2006	Shin et al.	370/338
*	D	US-2002/0126665	09-2002	Ueno, Tsukasa	370/389
*	E	US-7,123,599	10-2006	Yano et al.	370/331
*	F	US-7,039,028	05-2006	Chen et al.	370/331
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.